# Application/Control No. 10/088,884 Examiner Brian S Kwon Applicant(s)/Patent Under Reexamination FRANK, R. KEITH Art Unit Page 1 of 1

Notic of R ferences Cited

• • • •

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,288,846	11-1966	Irani et al.	562/16
*	В	US-4,898,724	02-1990	Simon et al.	424/1.77
	С	US-4,976,950	12-1990	Simon et al.	424/1.77
	D	US-4,882,142	11-1989	Simon et al.	424/1.77
	E	US-6,008,207	12-1999	Brenner et al.	514/108
*	F	US-5,385,893	01-1995	Kiefer, Garry E.	424/9.363
*	G	US-5,714,604	02-1998	Kiefer, Garry E.	540/472
*	Н	US-5,902,825	05-1999	Jia, Wei	514/492
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 94/00145	01-1994		Garlich et al.	
	0	EP 0411941 A2	06-1991		Galich et al.	
	Р					
	Q					
	R					
	s					,
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
*	U	Miller et al., Toxicology and Applied Pharmacology, vol. 77, no. 2, 1985, pages 230-239.		
*	v	Jee et al., Toxicology and Applied Pharmacology, vol. 92, no. 3, 1988, pages 335-342.		
*	w	Moore et al., Fundamental and Applied Toxicology, (1990 Apr) 14 (3), 491-501.		
*	х	Wang et al., Shuichuli Jishu, abstract, 1989, 15(6), 370-3.		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.